
**Metallic and oxide coatings —
Measurement of coating thickness —
Microscopical method**

*Revêtements métalliques et couches d'oxyde — Mesurage de
l'épaisseur de revêtement — Méthode par coupe micrographique*

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ISO copyright office
Case postale 56 • CH-1211 Geneva 20
Tel. + 41 22 749 01 11
Fax + 41 22 749 09 47
E-mail copyright@iso.org
Web www.iso.org

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO 1463 was prepared by Technical Committee ISO/TC 107, *Metallic and other inorganic coatings*, Subcommittee SC 2, *Test methods*.

This third edition cancels and replaces the second edition (ISO 1463:1982), which has been technically revised.

Metallic and oxide coatings — Measurement of coating thickness — Microscopical method

1 Scope

This International Standard describes a method for the measurement of the local thickness of metallic coatings, oxide layers, and porcelain or vitreous enamel coatings, by the microscopical examination of cross-sections using an optical microscope.

WARNING — The use of this document may involve the use of hazardous materials, operations and equipment. This document does not address any health hazard and safety issues associated with its use. It is the responsibility of the user to establish appropriate health and safety practices and to take suitable action to comply with any national and/or local regulations prior to its use.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 2064, *Metallic and other inorganic coatings — Definitions and conventions concerning the measurement of thickness*

3 Term and definition

For the purposes of this document the following term and definition apply.

3.1

local thickness

the mean of the thickness measurements, of which a specified number is made within a reference area

[3.4 of ISO 2064:1996]

4 Principle

A portion of the test specimen is cut out and mounted. The mounted cross-section is prepared by suitable techniques of grinding, polishing and etching. The thickness of the coating cross-section is measured by means of a calibrated scale.

NOTE These techniques will be familiar to experienced metallographers, but some guidance is given in Clause 5 and in Annex A for less experienced operators.

5 Factors relating to measurement uncertainty

5.1 Surface roughness

If the coating or its substrate has a rough surface, one or both of the interfaces bounding the coating cross-section may be too irregular to permit accurate measurement. (See A.5.)

5.2 Taper of cross-section

If the plane of the cross-section is not perpendicular to the plane of the coating, the measured thickness will be greater than the true thickness; e.g., an inclination of 10° to the perpendicular will contribute a 1,5 % error.

NOTE B.1 provides guidance on taper cross-section.

5.3 Deformation of coating

Detrimental deformation of the coating can be caused by excessive temperature or pressure during mounting and preparation of cross-sections of soft coatings or coatings that melt at a low temperature, and also by excessive abrasion of brittle materials during preparation of cross-sections.

5.4 Rounding of edge of coating

If the edge of the coating cross-section is rounded, i.e. if the coating cross-section is not completely flat up to its edges, the true thickness cannot be observed microscopically. Edge rounding can be caused by improper mounting, grinding, polishing or etching. It is usually minimized by overplating the test specimen before mounting. (See A.2.)

5.5 Overplating

Overplating of the test specimen protects the coating edges during preparation of cross-sections and thus prevents erroneous measurement. Removal of coating material during surface preparation for overplating can result in a low thickness measurement.

5.6 Etching

Optimum etching produces a clearly defined and narrow dark line at the interface of two metals. Excessive etching produces a poorly defined or wide line that can result in erroneous measurement.

5.7 Smearing

Improper polishing or overplating with a softer metal may cause smearing of one metal over the other metal, obscuring the boundary between the coating and the substrate. This problem may be alleviated by repeating the preparation of the cross section of the coated metal until repeatability of the thickness measurement (see A.3 and A.5) is obtained and also by over-plating with a harder metal.

5.8 Magnification

For any given coating thickness, measurement uncertainty generally increase with decreasing magnification. The magnification should be chosen so that the field of view is between $1,5 \times$ and $3 \times$ the coating thickness.

5.9 Calibration of stage micrometer

Any error in calibration of the stage micrometer will be reflected in the measurement of the specimen. Errors of several percent are not unrealistic unless the scale has been calibrated or has been certified by a responsible supplier. A generally satisfactory means of calibration is to assume that the stated length of the full scale is correct, to measure each subdivision with a filar micrometer, and to calculate the length of each sub-division by simple proportion.

5.10 Calibration of micrometer eyepiece

A filar micrometer eyepiece generally provides the most satisfactory means of making the measurement of the specimen. The measurement will be no more accurate than the calibration of the eyepiece. As calibration is operator dependent, the eyepiece shall be calibrated by the person making the measurement.

Repeated calibrations of the micrometer eyepiece can be reasonably expected to have a spread of less than 1 %. The distance between the two lines of a stage micrometer used for the calibration shall be known to within 0,2 μm or 0,1 %, whichever is the greater. If a stage micrometer is not certified for accuracy, it shall be calibrated.

NOTE The measurement uncertainty of some stage micrometers is certified by the manufacturer. Other stage micrometers have been found to have a measurement uncertainty of 1 μm or 2 μm for a measurement distance of 2 mm and by 0,4 μm and more for measurement distances of 0,1 mm and 0,01 mm.

Some image splitting micrometer eyepieces have a non-linearity that introduces an error of up to 1 % for short measurement distances.

5.11 Alignment

Errors can be introduced by backlash in the movement of the micrometer eyepiece. To eliminate this error, ensure that the final motion during alignment of the hairline is always made in the same direction.

5.12 Uniformity of magnification

Because errors can occur if the magnification is not uniform over the entire field, ensure that both the calibration and the measurement are made over the same portion of the field with the measured boundaries centred about the optical axis.

5.13 Lens quality

As lack of sharpness of the image contributes to the uncertainty of the measurement, ensure that good quality lenses are used.

NOTE Sometimes, image sharpness can be improved by using monochromatic light.

5.14 Orientation of eyepiece

Ensure that the movement of the hairline of the eyepiece for alignment is perpendicular to the boundaries of the coating cross-section; e.g., 10° misalignment will contribute a 1,5 % error.

5.15 Tube length

A change in tube length causes a change in magnification and, if this change occurs between the time of calibration and the time of measurement, the measurement will be in error. Take care to avoid a change in tube length, which can occur when the eyepiece is repositioned within the tube, when the focus of the eyepiece tube is changed and, for some microscopes, when the fine focus is adjusted.

6 Preparation of cross-sections

Prepare, mount, grind, polish, and etch the specimen so that:

- a) the cross-section is perpendicular to the coating;
- b) the surface is flat and the entire width of the coating image is simultaneously in focus at the magnification to be used for the measurement;
- c) all material deformed by cutting or cross-sectioning is removed;
- d) the boundaries of the coating cross-section are sharply defined by no more than contrasting appearance, or by a narrow, well defined, line.

NOTE Further guidance is given in Clause 5 and in Annex A. Some typical etchants are described in Annex C.

7 Measurement

7.1 Give appropriate attention to the factors listed in Clause 5 and Annex A.

7.2 Calibrate the microscope and its measuring device with a certified or calibrated stage micrometer.

7.3 Measure the width of the image of the coating cross-section on at least five points distributed along a length of the microsection.

NOTE Guidance on the measurement of taper of cross-section and of tooth-constructed coatings is given in Annex B.

8 Measurement uncertainty

The microscope and associated equipment, its use, its calibration and the method of preparation of the cross-section shall be chosen so as to allow the coating thickness to be determined to within 1 μm or 10 %, whichever is the greater, of the actual coating thickness. The method is capable of giving an absolute measurement uncertainty of 0,8 μm , and for thicknesses greater than 25 μm a reasonable measurement uncertainty is of the order of 5 % or better (see also B.3.). However, with careful preparation of the specimen and the application of suitable instruments this method is capable of providing a measurement uncertainty of 0,4 μm under reproducible conditions.

9 Test report

The test report shall include the following information:

- a) reference of this document, i.e. ISO 1463;
- b) identity of the test specimen;
- c) results of the test, indicating
 - 1) location on the coated item at which the cross-section was made;
 - 2) measured thickness, in micrometres (millimetres if greater than 1 mm) at each point (see 7.3);
 - 3) local thickness, i.e., the arithmetic mean of the measured thicknesses;
- d) any deviations from the procedure specified;
- e) any unusual features (anomalies) observed during the test;
- f) date of test.

Annex A (informative)

Guidance on the preparation and measurement of cross-sections

A.1 Introduction

The preparation of test specimens and measurement of coating thickness are greatly dependent on individual techniques and there is a variety of suitable techniques available. It is not reasonable to specify only one set of techniques, and it is impractical to include all suitable techniques. The techniques described in this annex are intended as guidance for metallographers not experienced in measurements of coating thickness.

A.2 Mounting

To prevent rounding of the edge of the coating cross-section, the free surface of the coating should be supported so that there is no space between the coating and its support. This is usually achieved by overplating the specimen with a coating of a metal of similar hardness, at least 10 μm thick. For hard, brittle coatings (e.g. oxide or chromium coatings), tightly wrapping the specimen in soft aluminium foil before mounting has proved successful.

If the coating is soft, overplating with a metal that is softer will make polishing more difficult, because the softer metal tends to be polished away more rapidly.

Overplating of zinc or cadmium coatings with copper can cause difficulty because of the tendency of dissolved copper to deposit on the coatings during subsequent etching. It is better to overplate zinc with cadmium and vice versa.

A.3 Grinding and polishing

It is essential to keep the cross-section surface of the mount perpendicular to the coating. This is facilitated by incorporating additional pieces of a similar metal near the outer edges of the plastic mounting, by periodically changing the direction of grinding (rotating through 90°) and by keeping the grinding time and pressure to a minimum. If, before grinding, reference marks are inscribed on the sides of the mount, any inclination from horizontal is easily measurable.

Grind the mounted test specimens on suitable abrasive paper, using an acceptable lubricant, such as water or white spirit, and apply minimum pressure to avoid bevelling of the surface. Initial grinding should employ 100 grade or 180 grade abrasive to reveal the true test specimen profile and to remove any deformed metal. Subsequently, use grades 240, 320, 500 and 600 without exceeding grinding times of 30 s to 40 s on each paper; alter the direction of scratches by 90° for each change of paper. A final polish for 2 min to 3 min on a rotating wheel charged with 4 μm to 8 μm diamond paste particles and lubrication with white spirit should suffice to remove scratches for final examination. If an especially high degree of surface finish is required, a further treatment, using diamond paste of approximately 1 μm particles, may be used.

If very soft materials are being prepared, abrasive particles can become embedded during grinding. This may be minimized by totally immersing abrasive papers in a lubricant during grinding or by using a copious flow of lubricant. If abrasive particles do become embedded, they may be removed by applying a short, light hand polish with metal polish after grinding and before diamond finishing or by one or more cycles of alternate etching and polishing.

A.4 Etching

Etching is usually advisable in order to promote contrast between the metal layers to remove traces of smeared metal and to develop a fine line at the boundary of the coating. Some typical etchants are given in Annex C.

A.5 Measurement

The measuring device may be a filar micrometer or a micrometer eyepiece. The latter has lower precision. An image splitting eyepiece is advantageous for thin coatings on rough substrate surfaces. Measurement of the image projected on a ground glass plate is usually less satisfactory because of the lack of sharpness of the image and poor legibility of the rule when the projected image is visible.

The measuring device should be calibrated at least once before and once after a measurement, unless repeated experience indicates otherwise.

When making calibration and coating measurements both should be made by the same operator, the stage micrometer and the coating should be centred in the field and each measurement at a point should be made at least twice and averaged.

For critical and referee measurements, all steps for preparation of cross-sections and measurement of coating thickness, from grinding with 600 grade or coarser abrasive, up to and including the determination of coating thickness, should be performed at least twice. With good techniques and equipment, and smooth coating and substrate surfaces, repeatability within 2 % or 0,5 μm , whichever is the greater, is reasonable.

Some microscopes are subject to a spontaneous movement of the stage relative to the objective, possibly due to non-uniform thermal effects from the light source. Such a movement during the measurement can cause an erroneous measurement at moderate and high magnifications. This can be minimized by completing the measurement quickly and by measuring each interval twice, once from left to right and once from right to left.

Annex B (informative)

Taper of cross-section and measurement of tooth-constructed coatings

B.1 Taper of cross-section

If the sample position deviates from the perpendicular (see Figure B.1), higher measuring values will be obtained (see 5.2).

The coating thickness d can be calculated using the following equation:

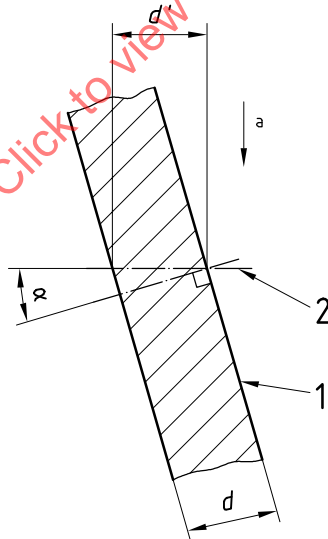
$$d = d' \cos \alpha$$

where

d is the coating thickness when $\alpha = 0$;

α is the deviation of the cross-section from the perpendicular of the coating surface, in degrees;

d' is the measured coating thickness when $\alpha \neq 0$.



Key

- 1 coating surface
- 2 section
- a Direction of observation

Figure B.1 — Deviation of the cross-section by the angle α

B.2 Measurement of tooth-constructed coatings

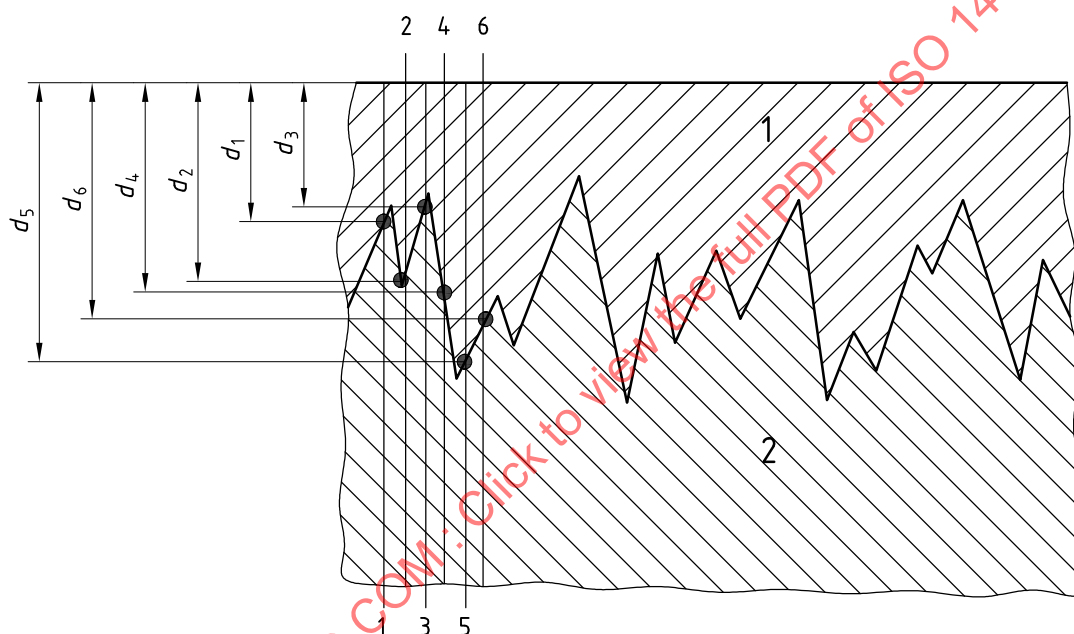
B.2.1 Principle

This method can be used for determining the coating thickness for coatings bounded by a tooth construction, e.g. thermochemically produced boride-nitride coatings.

The coating thickness is magnified $200\times$ and measured by a screen line distance of 2 mm between the boundary line of the coating over a suitable total length of, e.g. 100 mm (see Figure B.2).

B.2.2 Evaluation

The arithmetical average value for coatings with tooth-construction is calculated from single values. The standard deviation provides an indication of the irregularities of the boundary surface (i.e. the degree of tooth construction).



Key

- 1 coating
- 2 substrate

Figure B.2 — Diagrammatic representation of the thickness determination of coatings with tooth construction

B.3 Empirical values for the standard deviation of measurements obtained by light microscopy

Under reproducible conditions, the standard deviation, σ , is $0,3\text{ }\mu\text{m}$. Under comparable conditions, the standard deviation is $0,8\text{ }\mu\text{m}$.